

**Search Notes**

Application/Control No.

10/765,760

Examiner

Tai T. Nguyen

Applicant(s)/Patent under  
Reexamination

KHANDELWAL ET AL.

Art Unit

2612

**SEARCHED**

| Class | Subclass | Date     | Examiner |
|-------|----------|----------|----------|
| 340   | 531      | 7/7/2006 | TN       |
| 340   | 506      | 7/7/2006 | TN       |
| 340   | 539.1    | 7/7/2006 | TN       |
| 340   | 539.18   | 7/7/2006 | TN       |
| 340   | 500      | 7/7/2006 | TN       |
| 340   | 3.43     | 7/7/2006 | TN       |
| 340   | 7.29     | 7/7/2006 | TN       |
| 709   | 223      | 7/7/2006 | TN       |
| 709   | 224      | 7/7/2006 | TN       |
| 709   | 218      | 7/7/2006 | TN       |
| 370   | 356      | 7/7/2006 | TN       |
| 370   | 328      | 7/7/2006 | TN       |
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**INTERFERENCE SEARCHED**

| Class           | Subclass | Date     | Examiner |
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| SEARCH AS ABOVE |          | 7/7/2006 | TN       |

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

|             | DATE      | EXMR |
|-------------|-----------|------|
| EAST SEARCH | 11/7/2005 | TN   |
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